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2822 AF



Docket No.: 216648US-2

OBLON
SPIVAK
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P.C.

COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313

"RESPONSE UNDER 37 CFR 1.116-
EXPEDITED PROCEDURE EXAMINING
GROUP 2822"

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RE: Application Serial No.: 10/001,977

Applicants: Hiroyoshi TANIMOTO, et al.

Filing Date: December 5, 2001

For: SEMICONDUCTOR DEVICE, METHOD OF
MANUFACTURING SEMICONDUCTOR DEVICE,
AND SYSTEM FOR EVALUATING ELECTRICAL
CHARACTERISTICS OF SEMICONDUCTOR
DEVICE

Group Art Unit: 2822

Examiner: PERKINS, P. E.

FEB 20 2004

SIR:

Attached hereto for filing are the following papers:

REQUEST FOR RECONSIDERATION UNDER 37 C.F.R. § 1.116

Our check in the amount of \$0.00 is attached covering any required fees. In the event any variance exists between the amount enclosed and the Patent Office charges for filing the above-noted documents, including any fees required under 37 C.F.R. 1.136 for any necessary Extension of Time to make the filing of the attached documents timely, please charge or credit the difference to our Deposit Account No. 15-0030. Further, if these papers are not considered timely filed, then a petition is hereby made under 37 C.F.R. 1.136 for the necessary extension of time. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND,
MAIER & NEUSTADT, P.C.

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DOCKET NO: 216648US-2



"RESPONSE UNDER 37 CFR 1.116-
EXPEDITED PROCEDURE EXAMINING
GROUP 2822"

IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE APPLICATION OF :
HIROYOSHI TANIMOTO, ET AL. : EXAMINER: PERKINS, P. E.
SERIAL NO: 10/001,977 :
FILED: DECEMBER 5, 2001 : GROUP ART UNIT: 2822
FOR: SEMICONDUCTOR DEVICE, :
METHOD OF MANUFACTURING
SEMICONDUCTOR DEVICE, AND
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SEMICONDUCTOR DEVICE

FEB 20 2004

REQUEST FOR RECONSIDERATION UNDER 37 C.F.R. § 1.116

COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313

SIR:

In response to the Office Action dated November 18, 2003, Applicants request
reconsideration of the above-identified application.

Remarks begin on page 2 of this paper.